

Notice of References Cited	Application/Control No. 10/718,561	Applicant(s)/Patent Under Reexamination BAEK ET AL.	
	Examiner Leslie J. Evanisko	Art Unit 2854	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0081095	05-2003	Yi et al.	347/101
*	B	US-5,201,268	04-1993	Yamamoto et al.	101/170
	C	US-			
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	F	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

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